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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

				<b>Complete If Known</b>	
				Application Number	10/607,572
				Filing Date	June 27, 2003
				First Named Inventor	Keith W. Reiss
				Art Unit	2884
				Examiner Name	Taningco, Marcus H.
Sheet	1	of	2	Attorney Docket Number	8107.003.US

### U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
/MT/	A1	US-2,457,673	12-1948	HERSHBERGER WILLIAM D	
	A2	US-2,524,290	10-1950	HERSHBERGER WILLIAM D	
	A3	US-2,792,548	05-1957	HERSHBERGER WILLIAM D	
	A4	US-3,456,185	07-1969	AKAO et al.	
	A5	US-3,691,453	09-1972	RUPP et al.	
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	A7	US-4,181,437	01-1980	ROSSITER, Valentine J.	
	A8	US-4,364,008	12-1982	JACQUES, Steven L.	
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/MT/	A24	US-6,888,342	05-2005	BRADLEY, Donald A.	

### FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				

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### NON PATENT LITERATURE DOCUMENTS

Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
/MT/	C1	Carter, R. L. et al., Physical Review 1947, 72, 1265-1266.	
/MT/	C2	Costain, C. C., Canadian Journal of Physics 1957, 35, 241-247.	

Examiner Signature	/Marcus Taningco/	Date Considered	08/17/2007
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Sheet	2	of	2
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	C4	Britt, C. O., Review of Scientific Instruments 1967, 38, 1496-1501.
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	C6	Schiek, B. et al, Conference Proceedings – European Microwave Conference 7 <sup>th</sup> 1977, 251-255, Publisher: Microwave Exhibitions Publications Ltd., Sevenoaks, England.
	C7	Schiek, B. et al, Journal of Microwave Power 1977, 12, 347-359.
	C8	Hrubesh, L. W., Applied Spectroscopy 1978, 32, 425-429.
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	C19	Petkie, D. T. et al, Review of Scientific Instruments 1997, 68, 1675-1683.
	C20	Lewen, F. et al, Review of Scientific Instruments 1998, 69, 32-39.
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▼	C24	Van Der Weide, D. W., NATO Science Series, II: Mathematics, Physics and Chemistry 2001, 27, 301-314.
/MT/	C25	Albert, S. et al, FASSST: A New Gas-Phase Analytical Tool, Anaytical Chemistry News & Features, November 1, 1998, 719.

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